

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	79051	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:20
L2	1246279	image or imaging or imager	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:20
L3	25236	microscope or microscopic or microscopically	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L4	1015690	semiconductor or wafer or substrate or mask or die or reticle	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L5	84764	align or aligning or aligner or alignment	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L6	641008	detector or sensor or "ccd"	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L7	24374	magnify or magnification or magnifying	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L8	632670	switch or switching or shutter or shuttering	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L9	230	complex with phase with amplitude	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L10	12011	1 and 2	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L11	405	10 and 5	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:41
L12	147	10 and 7	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:23
L13	789	10 and 8	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L14	0	11 and 9	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L15	0	12 and 9	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L16	0	13 and 9	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L17	29	11 and 3	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:41
L18	34	linnik	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:43
L19	33	12 and 3	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:42
L20	13	13 and 3	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:42
S1	389	(356/450).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/11/04 13:55

S2	50	(356/456).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 11:32
S3	79	(356/489).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 13:19
S4	90	(356/495).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 13:24
S5	208	(356/511).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 13:34
S6	301	(356/512).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 14:06
S7	686773	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/07 12:20
S8	799365	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/07 12:20
S9	199634	microscope or microscopic or microscopically	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S10	1289596	semiconductor or wafer or substrate or mask or die or reticle	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S11	154761	S7 and S8	US-PGPUB; USPAT	OR	ON	2005/10/20 14:10
S12	30278	S11 and S9	US-PGPUB; USPAT	OR	ON	2005/10/20 14:10
S14	24878	S12 and S10	US-PGPUB; USPAT	OR	ON	2005/10/20 14:10
S15	733953	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S16	12719	S14 and S15	US-PGPUB; USPAT	OR	ON	2005/10/20 14:11
S17	856040	complex or imaginary	US-PGPUB; USPAT	OR	ON	2005/10/20 14:11
S18	8909	S16 and S17	US-PGPUB; USPAT	OR	ON	2005/10/20 14:11
S19	1264	"356"/\$.ccls. and S16	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S20	1048	"250"/\$.ccls. and S16	US-PGPUB; USPAT	OR	ON	2005/10/20 14:41
S21	540	"356"/\$.ccls. and S18	US-PGPUB; USPAT	OR	ON	2005/10/20 18:51
S22	366	"250"/\$.ccls. and S18	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S23	686773	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52

S24	799365	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S25	199634	microscope or microscopic or microscopically	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S26	1289596	semiconductor or wafer or substrate or mask or die or reticle	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S27	154761	S23 and S24	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S28	30278	S27 and S25	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S29	24878	S28 and S26	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S30	733953	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S31	12719	S29 and S30	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S32	856040	complex or imaginary	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S33	8909	S31 and S32	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S34	164	"356"/450-521.ccls. and S33	US-PGPUB; USPAT	OR	ON	2005/10/20 18:54
S35	3	("4818110" "6078392" "6262818"). PN.	US-PGPUB; USPAT	OR	ON	2005/10/21 09:45
S36	803660	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/03 15:41
S37	736612	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/11/03 15:41
S38	892306	detector or sensor or "ccd"	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S39	4424	S36 with S37 with S38	US-PGPUB; USPAT	OR	ON	2005/11/03 15:42
S40	860	"356"/\$.ccls. and S39	US-PGPUB; USPAT	OR	ON	2005/11/03 15:43
S41	689734	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/03 15:43
S42	1699	S39 and S41	US-PGPUB; USPAT	OR	ON	2005/11/03 15:43
S43	532	"356"/\$.ccls. and S42	US-PGPUB; USPAT	OR	ON	2005/11/03 15:44
S44	397	"250"/\$.ccls. and S42	US-PGPUB; USPAT	OR	ON	2005/11/03 16:19
S45	803660	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04

S46	736612	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S47	892306	detector or sensor or "ccd"	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S48	4424	S45 with S46 with S47	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S49	689734	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S50	1699	S48 and S49	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S51	97	"382"/\$.ccls. and S50	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S52	1	("re35350").PN.	US-PGPUB; USPAT	OR	OFF	2005/11/03 19:14
S53	5	("RE35350").URPN.	USPAT	OR	ON	2005/11/03 19:15
S54	6	("5276337").URPN.	USPAT	OR	ON	2005/11/03 19:15
S55	218	linnik	US-PGPUB; USPAT	OR	ON	2005/11/04 15:18
S56	21	("4732483").URPN.	USPAT	OR	ON	2005/11/04 14:04
S57	56	("5112129").URPN.	USPAT	OR	ON	2005/11/04 14:07
S58	49	("4818110").URPN.	USPAT	OR	ON	2005/11/04 14:09
S59	12	("5112125").URPN.	USPAT	OR	ON	2005/11/04 14:22
S60	95409	magnify or magnification	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S61	803660	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/04 14:22
S62	892306	detector or sensor or "ccd"	US-PGPUB; USPAT	OR	ON	2005/11/04 14:22
S63	4269	S60 with S61 with S62	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S64	444	"382"/\$.ccls. and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:25
S65	597	"356"/\$.ccls. and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:26
S66	714	"250"/\$.ccls. and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:26
S67	689734	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/04 14:25
S68	1504	S67 and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:25

S69	111	"382"/\$.ccls. and S68	US-PGPUB; USPAT	OR	ON	2005/11/04 14:26
S70	333	"356"/\$.ccls. and S68	US-PGPUB; USPAT	OR	ON	2005/11/04 14:37
S71	243	"250"/\$.ccls. and S68	US-PGPUB; USPAT	OR	ON	2005/11/04 14:55
S72	35	("4751376").URPN.	USPAT	OR	ON	2005/11/04 15:12
S73	160	S55 and S61	US-PGPUB; USPAT	OR	ON	2005/11/04 15:21
S74	1071558	switch or switching or shutter or shuttering	US-PGPUB; USPAT	OR	ON	2005/11/07 12:22
S75	42	S73 and S74	US-PGPUB; USPAT	OR	ON	2005/11/04 15:57
S76	5	((("6078392") or ("6262818") or ("5572598") or ("5583639") or ("5471303"))).PN.	US-PGPUB; USPAT	OR	OFF	2005/11/04 15:57
S77	4166	complex with phase with amplitude	US-PGPUB; USPAT	OR	ON	2005/11/07 12:22
S78	1528	S61 and S77	US-PGPUB; USPAT	OR	ON	2005/11/04 16:56
S79	1019	S67 and S78	US-PGPUB; USPAT	OR	ON	2005/11/04 16:56
S80	12	S55 and S79	US-PGPUB; USPAT	OR	ON	2005/11/04 16:56